

Class
Subclass
Issue Classification

5962369

UTILITY SERIAL NUMBER 00/183800 PATENT OCT 05 1999 PATENT NUMBER

01 800 1/94 25 SUBCLASS 49 GROUP ART UNIT 2508 2800 EXAMINER CRANE

SHUNPEI YAMAZAKI, TOKYO, JAPAN; HONGYONG ZHANG, KANAGAWA, JAPAN; NAOTO KUSUMOTO, KANAGAWA, JAPAN; YASUHIKO TAKEMURA, KANAGAWA, JAPAN.

CONTINUING DATA***
VERIFIED THIS APPLN IS A CON OF 07/852,517 03/17/92 ABN
AND A CIP OF 07/933,718 8/24/92 U.S. Patent No. 5,296,405
WHICH IS A CON OF 07/520,998 5/9/90 U.S. Patent No. 5,171,710
WHICH IS A CIP OF 07/251,940 9/28/88 U.S. Patent No. 4,986,283
WHICH IS A CON OF 06/891,791 8/1/96 ABN

FOREIGN/PCT APPLICATIONS***
VERIFIED FED REP GERMANY 3-80799 03/18/91
JAPAN

NOTE/DISCLAIMER
The term of this patent shall not extend beyond the expiration date of Pat. No. 5,262,654.

Foreign priority claimed: ☒ yes ☐ no
35 USC 119 conditions met: ☒ yes ☐ no
Verified and Acknowledged: Examiner's Initials AS FILED JPX 6 15 4 \$784.00 0756958

STIXBEY, FRIEDMAN, LEEDOM & FERGUSON
2010 CORPORATE RIDGE
SUITE 600
MCLEAN, VA 22102
BEST AVAILABLE COPY

SEMICONDUCTOR MATERIAL AND METHOD FOR FORMING THE SAME AND THIN FILM TRANSISTOR

U.S. DEPT. of COMM. Pat. & TM. Office PTO-436L (rev. 10-78)

PARTS OF APPLICATION FILED SEPARATELY
Applications Examiner

NOTICE OF ALLOWANCE MAILED
4-13-99
Assistant Examiner
Amount Due 1200 Date Paid 12-15-99
Primary Examiner
PREPARED FOR ISSUE
CLAIMS ALLOWED
Total Claims 34
Print Claim
DRAWING
Sheets Drawn 6 Figs. Drawn 8
ISSUE BATCH NUMBER R-78

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Form PTO-436A
Rev. 8/92

FORM FEE IN FILE

Formal Drawings (shs) set

(FACE)

PATENT NUMBER

ORIGINAL CLASSIFICATION

CLASS

SUBCLASS

APPLICATION SERIAL NUMBER

08/183,800

CROSS REFERENCE(S)

CLASS

SUBCLASS
(ONE SUBCLASS PER BLOCK)

APPLICANT'S NAME (PLEASE PRINT)

YAMAZAKI ET AL.

PREVIOUS, ORIGINAL PATENT NUMBER

INTERNATIONAL CLASSIFICATION

H01L 29/04

GROUP
ART UNIT

2811

ASSISTANT EXAMINER (PLEASE STAMP OR PRINT FULL NAME)

PRIMARY EXAMINER (PLEASE STAMP OR PRINT FULL NAME)

SARA W. CRANE

ISSUE CLASSIFICATION SLIP

U.S. DEPARTMENT OF COMMERCE
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